


<b>Search Notes</b>  	<b>Application/Control No.</b>  10823449	<b>Applicant(s)/Patent Under Reexamination</b>  BECK ET AL.
	<b>Examiner</b>  CHI Q NGUYEN	<b>Art Unit</b>  3635

SEARCHED			
Class	Subclass	Date	Examiner
52	262-264, 649.1, 650.1, 650.3, 651.11, 653.1, 654.1, 655.1, 656.1, 656.9, 702, 712, 289, 741.1	2/1/2008	cn

SEARCH NOTES		
Search Notes	Date	Examiner
PALM inventor name; BRS search; Search related art (FW and BW)	2/1/2008	cn

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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